

**Lecture Erasmus+  
course on Machine  
Learning, October  
23, 2023**

Cost function

$$C(\beta) = \sum_{i=0}^{n-1} L(y_i, x_i; \beta)$$

$$\left( \frac{1}{n} \sum_{i=0}^{n-1} (y_i - \hat{y}_i)^2 \right. \\ \left. = \frac{1}{n} \sum_{i=0}^{n-1} \left( y_i - \sum_{j=0}^{p-1} x_{ij} \beta_j \right)^2 \right)$$

$$MSE = E\left(\|y - X\beta\|^2\right) \leftarrow \begin{matrix} \text{sample} \\ MSE \end{matrix}$$

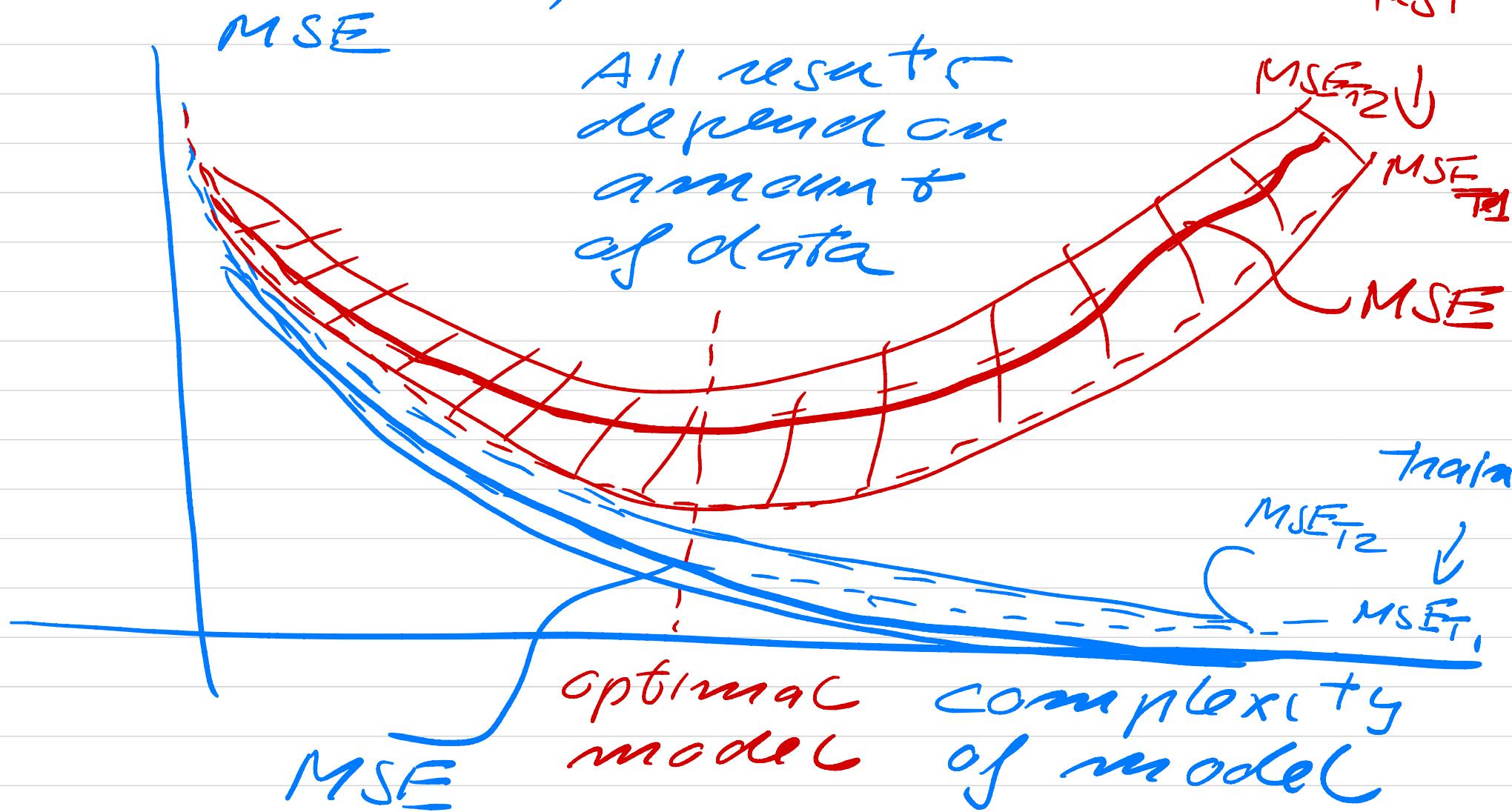
$$E[X^n] = \int_{x \in D} x^n p(x) dx$$

$\uparrow$   
unknown

$$\mu = E[X] = \int_{x \in D} x p(x) dx$$

$$\neq \bar{x} = \frac{1}{n} \sum_{i=0}^{n-1} x_i \leftarrow \begin{matrix} \text{sample} \\ median \end{matrix}$$

Calculate training MSE and  
Test MSE with different (but  
limited)



$$MSE_{Train} = \frac{1}{B} \sum_{i=1}^B MSE_{Train}(i)$$

$$MSE_{Test} = \frac{1}{B} \sum_{i=1}^B MSE_{Test}(i)$$

Resampling techniques are used to generate "new" data in order to obtain better estimators of statistical expectation values

Bootstrap (often small  
data sets n~100-1000)

$$\mathcal{D} = \{x_0, x_1, x_2, \dots, x_{n-1}\}$$

algorithm

- (i) Reshuffle  $\mathcal{D}$  randomly  
with replacement

$$\mathcal{D}_1 = \{x_0^*, x_1^*, x_2^*, \dots, x_{n-1}^*\}$$

$$\mathcal{D} = \{1, 2, 3, 4\}$$

$$\mathcal{D}_1 = \{2, 3, 1, 1\}$$

calculate expectation  
values,  $\mu_1$ ,  $\sigma^2$  etc

(ii) Repeat (i)  $B$ -times

(iii) calculate

$$\mu = \frac{1}{B} \sum_{i=1}^B \mu_i'$$

$$MSE = \frac{1}{B} \sum_{i=1}^B MSE(i')$$

Example: Gaussian with

$$n=10^4, \mu=100, \sigma=15$$

Perform m-bootstrap

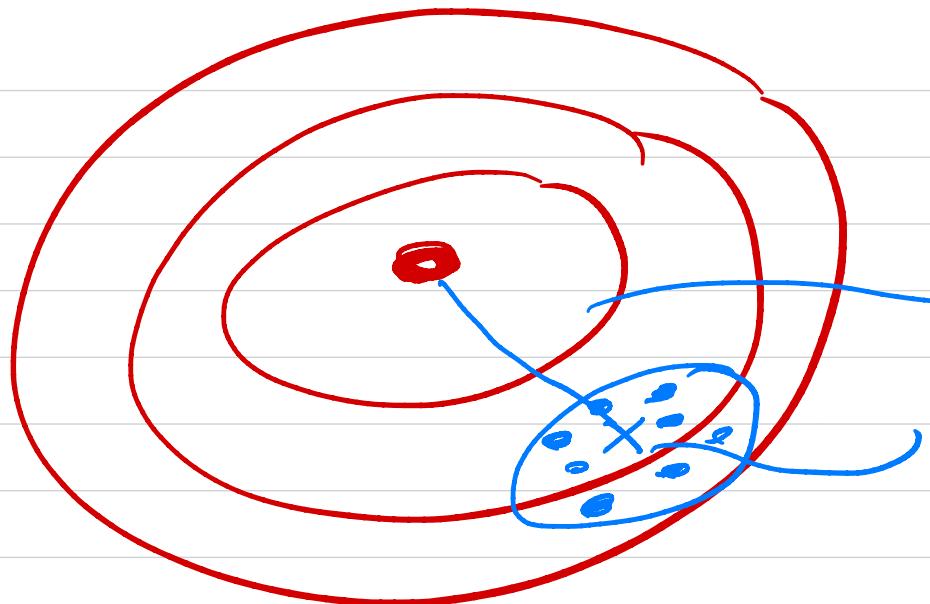
$\sigma_m \approx \sqrt{\hat{\sigma}_m}$ , follows  
from Central Limit theorem.  
 $\mu_n = \mu_m$

$$MSE = \text{Bias} + \text{var}[f] + \sigma^2$$

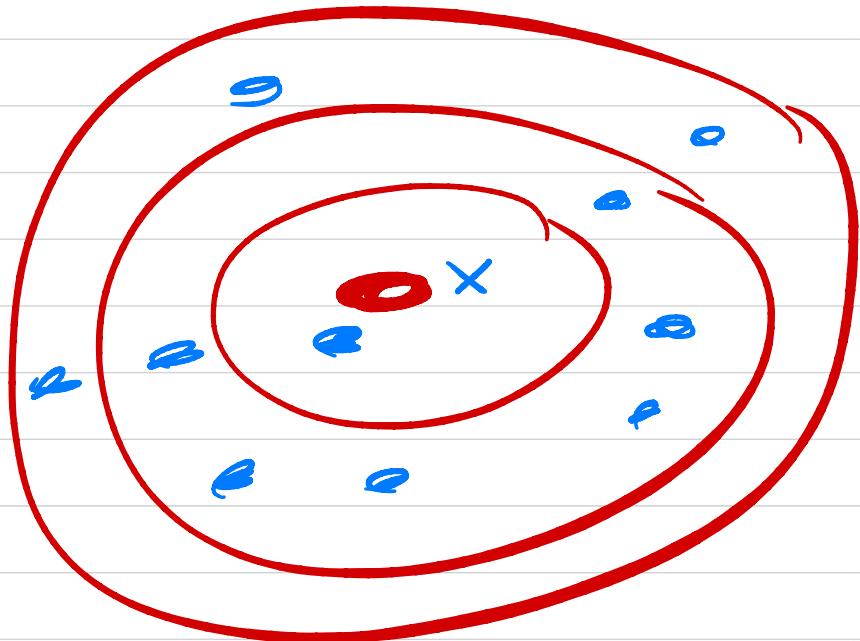
$$\frac{1}{n} \sum_{i=0}^{n-1} (y_i - E[y])^2$$

$$\frac{1}{n} \sum_{i=0}^{n-1} (\tilde{y}_i - E[\tilde{y}])^2$$

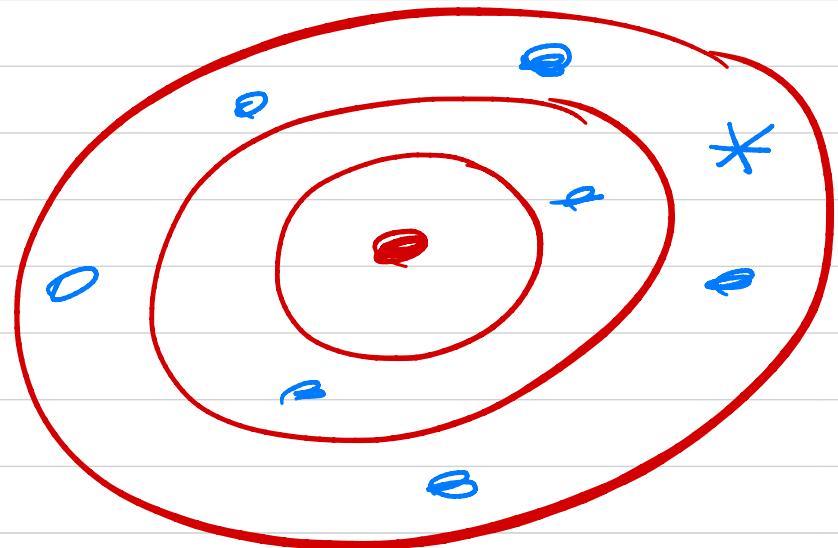
variance of  
model



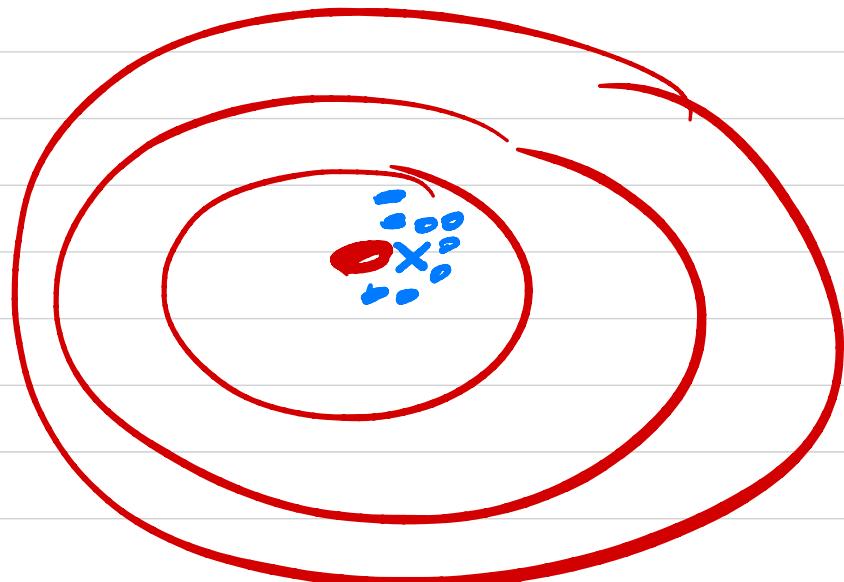
Bias high  
variance low  
large deviation  
from  $\hat{y}$   
 $E[\hat{y}]$   $\Rightarrow$  large  
Bias



Low Bias  
high variance  
(overfitting)



high Bias  
high variance  
overfitting



Low Bias  
low variance  
ideal